

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/583,743	HAYAKAWA ET AL.	
Examiner	Art Unit	
Vivian Chen	1773	

SEARCHED				
Class	Subclass	Date	Examiner	
				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST text search printout	6/22/2007	NC/	
inventor search	6/22/2007	NC/	
EAST text search printout	6/25/2007	NC/	